

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In we application of	
In re application of:	CERTIFICATE OF MAILING
Ulrich Müller, et al.	BY "EXPRESS MAIL"
Serial No.: 10/677,880) "Express Mail" Mailing Label: EV 321710202 US) Date of Deposit: October 27, 2003
Filed: October 2, 2003) I hereby certify that this paper or fee is being
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Examiner:	"Express Mail Post Office Box Addressee" service under 37 CFR 1.10 on the date indicated above
) and is addressed to: Commissioner for Patents,
Art Unit:) P.O. Box 1450, Alexandria, VA 22313-1450
	NAME: ARMANDO CHING
For: FLATNESS MEASUREMENT SYSTEM	
FOR METAL STRIP) SIGNATURE: Chinands China

Commissioner for Patents
Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Dear Sir:

Pursuant to 37 C.F.R. §1.97, Applicant hereby calls the Examiner's attention to documents listed on the attached form, which documents may be material to the examination of this application. The documents listed on Page 1 of the attached Form PTO/SB/O8A include those documents that were cited by or submitted to the Patent Office in the parent application, Serial No. 09/034,481, filed March 4, 1998, which is being relied upon for an earlier filing date under 35 USC 120. Accordingly, pursuant to 37 C.F.R. §1.98(d), copies of those documents are not being submitted herewith. If copies of such documents are

not available to the Examiner or are otherwise required,
Applicant will gladly provide them. The additional pages of
Form PTO/SB/08A and PTO/SB/08B include newly submitted
references Nos. 1-26, of which copies are included.

No inference should be drawn that the attached list sets forth a comprehensive investigation of the prior art, that any or all are pertinent to the invention, or that any apparatus disclosed is equivalent to the subject invention.

The citation of the above-discussed documents is not to be construed as an assertion that more pertinent art could not possibly be in existence. Citation of any document herein is not to be construed as an admission that any subject matter disclosed in the document is necessarily within the inventive field of endeavor, that any disclosure is necessarily prior in time to a particular date which may be relevant to the instant patent application, and/or that any disclosure is otherwise necessarily prior art with respect to the instant invention.

Applicant also respectfully reserves the right to later set forth how the instant invention is distinguished over the disclosure of any document or other art, including the disclosure of those documents discussed herein, that may be cited by the Examiner in rejecting a claim in the instant patent application.

This Information Disclosure Statement is being filed before the mailing date of a first Office Action on the merits. Accordingly, it is believed that no fee under 37 CFR 1.97(c) is required. If it is determined that a fee is required for this Information Disclosure Statement, please charge our Deposit Account No. 50/1039.

Respectfully submitted,

Andrew G. Kolomayets Registration No. 33,723

COOK, ALEX, MCFARRON, MANZO, CUMMINGS & MEHLER, LTD. 200 West Adams Street - #2850 Chicago, IL 60606 (312) 236-8500 OCT 2 7 2003 PTO/SB/08A (04-03) Approved for use through 04/30/2003. OMB 0651-0031 U.S. Patent and Trademark Office; U.S. DEPARTMENT OF COMMERCE

INFORMATION DISCLOSURE
STATEMENT BY APPLICANT

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Sheet

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	Application Number	10/677,880		
ON DISCLOSURE	Filing Date	October 2, 2003		
	First Named Inventor	Uljrich Muller, et al.		
BY APPLICANT	Art Unit			
sheets as necessary)	Examiner Name			
of 4	Attorney Docket Number	0329-0009.01		

Examiner Initials*	Cite No. ¹	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code ^{2 (F known)} US- 3,731,508	05/00/4072	Cabatini at al	Figures Appear
		3,731,506	05/08/1973	Sabatini et al.	
		^{US-} 4,782,683	11/08/1988	Tippins et al.	
		^{US-} 4,785,646	11/22/1988	Uekaji et al.	
		^{US-} 4,809,528	03/07/1989	Lawson et al.	
		^{US-} 5,016,281	05/1991	Eppler et al.	
		^{US-} 5,085,066	02/04/1992	Komami et al.	
		^{US-} 5,309,222	05/03/1994	Kamei et al.	
		^{US-} 5,367,378	11/22/1994	Harding et al.	
		^{US-} 5,488,478	01/30/1996	Bullock et al.	
		^{US-} 5,996,384	12/07/1999	Steeper et al.	
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Examiner Initials*	Cite No.1	Foreign Patent Document	Publication Date	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages	
		Country Code ³ Number ⁴ Kind Code ⁵ (if known)	MM-DD-YYYY		Or Relevant Figures Appear	T
		DE OS 20 13 867	10/07/1971			~
		JP 62-9711	01/17/1987			~
		DE 37 21 746	01/19/1989			V
		JP 2-229610	06/12/1990			~
		FR 2 725 512	04/12/1996			V

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See Kinds Codes of USPTO Patent Documents at www.uspto.gov or MPEP 901.04.

Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3).

For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document.

Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible.

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Application Number 10/677,880

Filing Date October 2, 2003

First Named Inventor Uljrich Muller, et al.

Art Unit

Examiner Name

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Sheet 2 of 4 Attorney Docket Number 0329-0009.01

Examiner Initials*	Cite No. ¹	Document Number Number-Kind Code ^{2 (# known)}	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
	1	^{US-} 4,634,279	01/06/1987	Ross et al.	
	2	^{US-} 5,155,363	10/13/1992	Steinbichler et al.	
	3	^{US-} 5,175,601	12/29/1992	Fitts	
	4	^{US-} 5,225,890	07/06/1993	Lee et al.	
	5	^{US-} 5,307,152	04/26/1994	Boehnlein et al.	
	6	^{US-} 5,359,668	10/25/1994	Lahaije et al.	
	7	^{US-} 5,448,359	09/05/1995	Schick et al.	
	8	^{US-} 5,505,113	04/09/1996	Wiest	
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		Country Code ³ Number ⁴ Kind Code ⁵ (if known)	MM-DD-YYYY		Or Relevant Figures Appear	T ⁶
	9	EP 0 470 815 A1	02/12/1992	Industrial Technology Inst.		~
	10	DE 41 42 564 A1	06/24/1993	Fa. Carl Zeiss		
	11	WO 94/05968 A1	03/17/1994	John M. Fitts		
	12	FI 950748	08/18/1996	Spectra-Physics Visiontech		
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of 1995, no persons are required to respond to a collection of information unless it contains a valid OMB control number. C mpl te if Known Substitute for form 1449/PTO **Application Number** 10/677,880 INFORMATION DISCLOSURE Filing Date October 2, 2003 STATEMENT BY APPLICANT **First Named Inventor** Ulrich Muller, et al. Art Unit (Use as many sheets as necessary) **Examiner Name** Attorney Docket Number Sheet 3 of 0329-0009.01

Examiner	Cite	OTHER PRIOR ART-NON PATENT LITERATURE DOCUMENTS Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of	
Initials*	No.1	the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²
	13	LIPPINCOTT, ET AL., "Optical-Digital Detection of Dents and Scratches on Specular Metal Surfaces," Applied Optics, August 15, 1982, pp. 2875-2881, Vol. 21, No. 16.	
	14	PIRLET, R, ET AL., "A Noncontact System for Measuring Hot Strip Flatness," Iron and Steel Engineer, July 1983, pp. 45-50,	
	15	H. MARGUERRE, "Automatisierte Qualitatsprufung glanzender Oberflachen an Gebrauchsgegenstanden durch strukturierte Beleuchtung," Feinwertechnik & Messtechnik 93, 1985, pp. 35-37.	
	16	"Hot Strip Mill Profile and Flatness Study - Phase I," Association of Iron and Steel Engineers," October 1986, pp. 10-13 and 31-33.	
	17	"Hot Strip Mill Profile and Flatness Study - Phase II," Association of Iron and Steel Engineers," July 1989, pp. 59 and 108.	
	18	DITZHUIJZEN, ET AL., "36 Performance Increase of Hot Strip Mills After Renovation," Dimensional Control in Rolling Mills, September 11-13, 1990, Imperial College, London, UK, pp. 321-333, Vol. 1.	~
	19	BREUCKMANN, B., ET AL., "Sensoren und Gerate fur die 3D-Mebtechnik," Fertigungsmesstechnik, 1992, pp. 383-386, Verlag, Munchen.	
	20	GMA-Bericht 23, "Optisches Messen von Lange und Gestalt," (Manuskripte der Beitrage zum VDI/VDE-Aussprachetag, 11 and 12, October 1994, Dusseldorf, Germany.	
	21	KANTOLA, PEKKA, ET AL., "A New Solution to Flatness Measurement," Steel Times, August 1995, pp. 296, 298, Rautarukki Oy, Finland.	
	22	VASCOTTO, MARCO, "High Speed Surface Defect Identification on Steel Strip," MPT International, April 1996, pp. 70, 72-73, Trento (TN), Italy.	

Examiner	Date
Signature	Considered

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STATEMENT BY APPLICANT	First Named Inventor	Ulrich Muller, et al.
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Sheet 4 of 4	Attorney Docket Number	0329-0009.01

		OTHER PRIOR ART-NON PATENT LITERATURE DOCUMENTS	
Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), titl the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-is number(s), publisher, city and/or country where published.	
	23	BREUCKMANN, BERND, ET AL., "Industrielle Praxis der topometrischen 3D-Messtechnik," (Industrial applications of topometrical 3D-metrology) pp. 195 and 200.	
	24	BREUCKMANN, BERND, ET AL., "Bildverarbeitung und optische Messtechnik in der industriellen Praxis,", Franzis', pp. 124-154.	
	25	GERSPACHER, PIRMIN, ET AL., "Beruhrungslose Ebenheits-prufung und Oberflachen-inspection," Vol. 12, pp. 256, 265, and 275.	
	26	BREUCKMANN, "Prospekt optoSIS S/S Oberflachen-Inspektions-System.	

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